

<b>Notice of References Cited</b>	Applicant/Patent <b>Shen</b>	Application/Control No. <b>09/407,204</b>	
	Examiner <b>Nitin Parekh</b>	Art Unit <b>2811</b>	Page 1 of 1

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<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.

**Notice of References Cited**

Application/Control No.

09/407,204

Applicant(s)/Patent Under Reexam

Shen

Examiner

Nitin Parekh

Art Unit

2811

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